

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CE0}	25	Vdc
Collector-Base Voltage	V_{CB0}	30	Vdc
Emitter-Base Voltage	V_{EB0}	3.0	Vdc
Collector Current — Continuous	I_C	50	mAdc
Total Device Dissipation @ $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	625 5.0	mW mW/°C
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	625 12	Watt mW/°C
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	83.3	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA(1)}$	200	°C/W

2N5208

TO-92

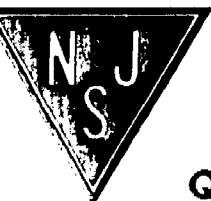
**GENERAL PURPOSE
TRANSISTOR**

PNP SILICON

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Breakdown Voltage ($I_C = 1.0 \text{ mAdc}, I_B = 0$)	$V_{(BR)CEO}$	25	—	Vdc
Collector-Base Breakdown Voltage ($I_C = 0.1 \text{ mAdc}, I_E = 0$)	$V_{(BR)CBO}$	30	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 10 \mu\text{A}, I_C = 0$)	$V_{(BR)EBO}$	3.0	—	Vdc
Collector Cutoff Current ($V_{CB} = 10 \text{ Vdc}, I_E = 0$)	I_{CBO}	—	10	nA dc
Emitter Cutoff Current ($V_{BE} = 2.0 \text{ Vdc}, I_C = 0$)	I_{EBO}	—	100	nA dc
ON CHARACTERISTICS				
DC Current Gain ($I_C = 2.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}$)	h_{FE}	20	120	—
Base-Emitter On Voltage ($I_C = 2.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}$)	$V_{BE(on)}$	—	0.85	Vdc
SMALL-SIGNAL CHARACTERISTICS				
Current-Gain — Bandwidth Product ($I_C = 2.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}, f = 100 \text{ MHz}$)	f_T	300	1200	MHz
Input Capacitance ($V_{BE} = 2.0 \text{ Vdc}, I_C = 0, f = 1.0 \text{ MHz}$)	C_{ibo}	—	4.0	pF
Collector-Base Capacitance ($V_{CB} = 10 \text{ Vdc}, I_E = 0, f = 1.0 \text{ MHz}$)	C_{cb}	—	1.0	pF
Collector Base Time Constant ($I_E = 2.0 \text{ mAdc}, V_{CB} = 10 \text{ Vdc}, f = 31.8 \text{ MHz}$)	$r_b'C_c$	—	10	ps
Noise Figure ($I_C = 2.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}, R_S = 75 \text{ ohms}, f = 100 \text{ MHz}, BW = 1.0 \text{ MHz}$)	NF	—	3.0	dB
FUNCTIONAL TEST				
Amplifier Power Gain ($I_C = 2.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}, f = 100 \text{ MHz}$)	G_{pe}	22	—	dB

(1) $R_{\theta JA}$ is measured with the device soldered into a typical printed circuit board.



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Quality Semi-Conductors